

Data and signal line chokes

Common-mode chokes, ring core 0.005 ... 47 mH, 100 ... 1200 mA, +60 °C

Series/Type: B82793C0/S0

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Data and signal line chokes

B82793C0/S0

Common-mode chokes, ring core

<u>SMD</u>

Rated voltage 42 V AC/80 V DC Rated inductance 0.005 ... 47 mH Rated current 100 ... 1200 mA

-18 ABB2763 -18 7421

Construction

- Current-compensated double choke
- Ferrite core
- LCP case (UL 94 V-0), silicone potting
- Bifilar winding (B82793C0)
- Sector winding (B82793S0)

Features

- High rated currents, reduced components height
- Qualified to AEC-Q200 (L ≤ 4.7 mH)
- Suitable for reflow soldering
- RoHS-compatible

Function

■ B82793C0:

Suppression of asymmetrical interference coupled in on lines, whereas data signals up to some MHz can pass unaffectedly.

■ B82793S0:

Suppression of asymmetrical and symmetrical interference (by L_{stray}) coupled in on lines. The high-frequency portions of the symmetrical data signal are decreased so far that EMC problems can be significantly reduced.

Applications

- Automotive applications, e.g. CAN bus
- Industrial applications
- Types with L_R > 4.7 mH only for telecom applications

Terminals

- Base material CuSn6
- Layer composition Ni, Sn
- Hot-dipped

Marking

- Marking on component: Manufacturer, process location (coded), winding method (coded), ordering code (short form), date of manufacture (YWWD)
- Minimum data on reel: Manufacturer, ordering code,
 L value and tolerance, quantity, date of packing

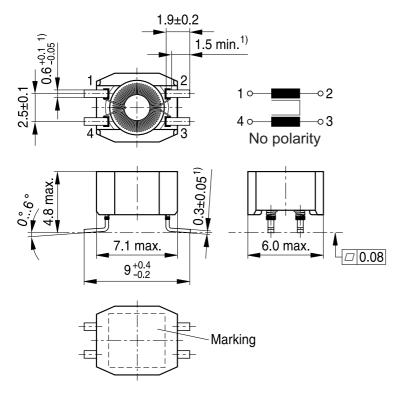
Delivery mode and packing unit

- 16-mm blister tape, wound on 330-mm Ø reel
- Packing unit: 1500 pcs./reel

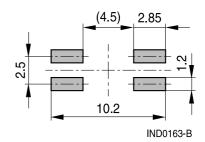
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Dimensional drawing and pin configuration



Layout recommendation



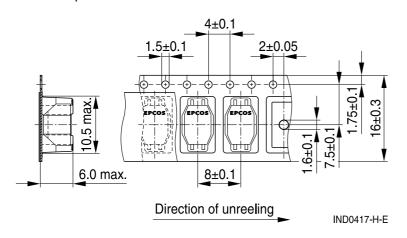
1) Soldering area

IND0010-9-E

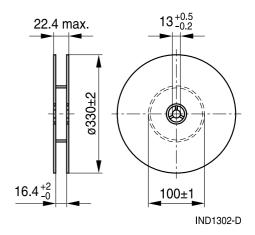
Dimensions in mm

Taping and packing

Blister tape



Reel



Dimensions in mm



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Technical data and measuring conditions

42 V AC (50/60 Hz) / 80 V DC			
+60 °C			
Referred to 50 Hz and rated temperature			
Measured with Agilent 4284A, 0.1 mA, +20 °C Measuring frequency: $L_R \le 1$ mH = 100 kHz $L_R > 1$ mH = 10 kHz Inductance is specified per winding.			
$\pm 30\%$ (L _R ≤ 0.47 mH), $-30/+50\%$ (L _R ≥ 1 mH) at +20 °C			
< 10% at DC magnetic bias with I _R , +20 °C			
Measured with Agilent 4284A, 5 mA, +20 °C, typical values Measuring frequency: L $_R \le$ 11 μH = $$ 1 MHz $$ L $_R >$ 11 μH = 100 kHz			
Measured at +20 °C, typical values, specified per winding			
SnPb: $+(215 \pm 3)$ °C, (3 ± 0.3) s Sn96.5Ag3.0Cu0.5: $+(245 \pm 5)$ °C, (3 ± 0.3) s Wetting of soldering area $\geq 95\%$ (to IEC 60068-2-58)			
+(260 ±5) °C, (10 ±1) s (to IEC 60068-2-58)			
40/125/56 (to IEC 60068-1)			
–25 °C +40 °C, ≤75% RH			
Approx. 0.25 g			



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Characteristics and ordering codes

L_R	L _{stray,typ}	I _R	R _{typ}	V _{test}	Ordering code	
mH	nH	mA	m $Ω$	V DC, 2 s		
0.005	40	1200	60	250	B82793C0502N201	
0.011	50	800	80	250	B82793C0113N201	
0.025	60	800	110	250	B82793C0253N201	
0.025	1400	800	110	250	B82793S0253N201	
0.051	70	800	140	250	B82793C0513N201	
0.051	2300	800	140	250	B82793S0513N201	
0.10	100	500	180	250	B82793C0104N201	
0.47	100	700	170	750	B82793C0474N215	
1.0	70	700	140	750	B82793C0105N265	
2.2	120	500	400	750	B82793C0225N265	
4.7	250	400	550	750	B82793C0475N265	
For telecommunications						
20	300	100	1800	750	B82793C0206N265	
47	1200	100	3700	750	B82793C0476N265	

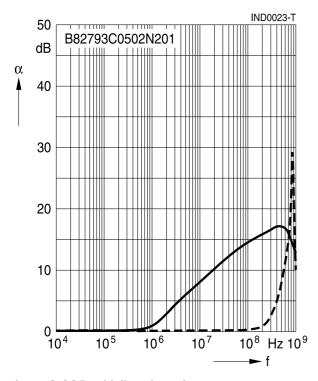
SMD

Insertion loss α (typical values at $|Z| = 50 \Omega$, +20 °C)

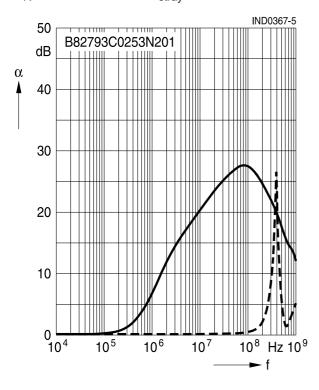
asymmetrical, all branches in parallel (common mode)

- - - - - - symmetrical (differential mode)

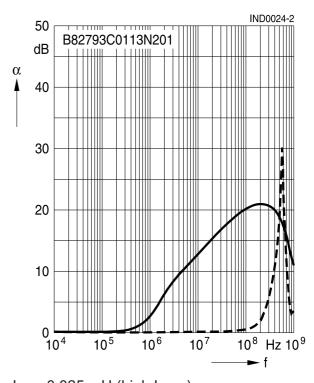
$$L_{R} = 0.005 \text{ mH}$$



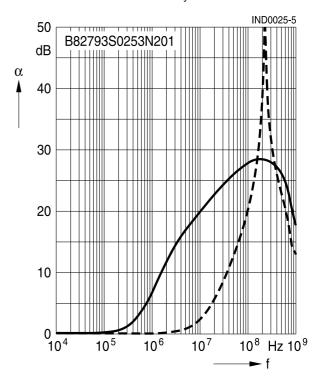
 $L_R = 0.025 \text{ mH (low } L_{\text{stray}})$



$$L_R = 0.011 \text{ mH}$$



 $L_R = 0.025 \text{ mH (high } L_{stray})$



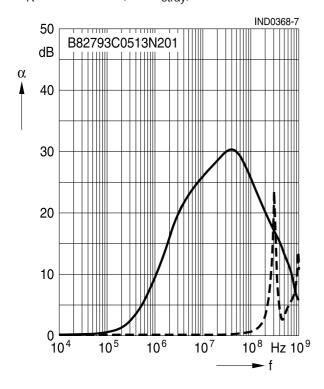
SMD

Insertion loss α (typical values at $|Z| = 50 \Omega$, +20 °C)

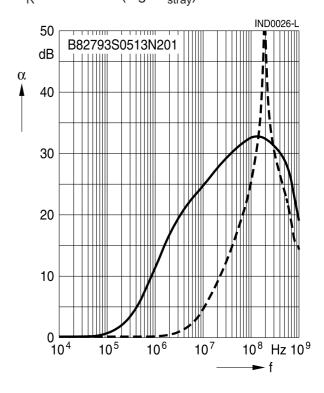
asymmetrical, all branches in parallel (common mode)

- - - - - - symmetrical (differential mode)

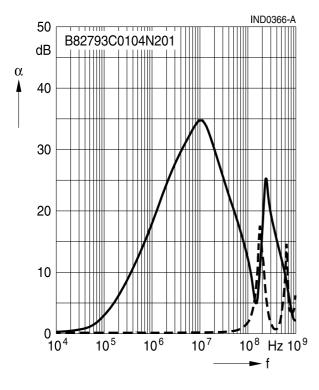
$$L_R = 0.051 \text{ mH (low } L_{stray})$$



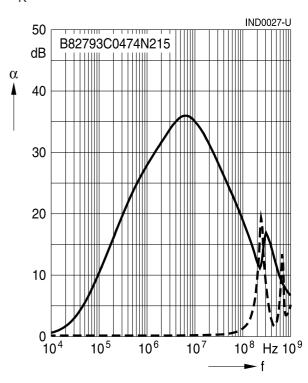
$$L_R = 0.051 \text{ mH (high } L_{stray})$$



 $L_{R} = 0.10 \text{ mH}$



 $L_{R} = 0.47 \text{ mH}$



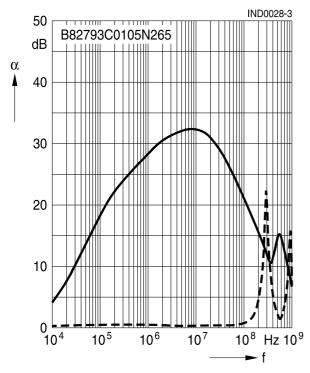
SMD

Insertion loss α (typical values at $|Z| = 50 \Omega$, +20 °C)

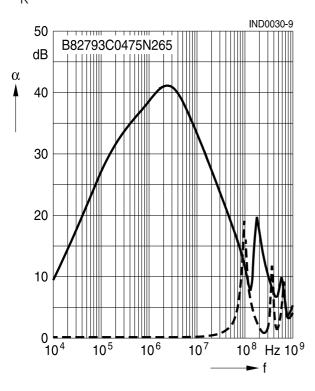
asymmetrical, all branches in parallel (common mode)

- - - - - - symmetrical (differential mode)

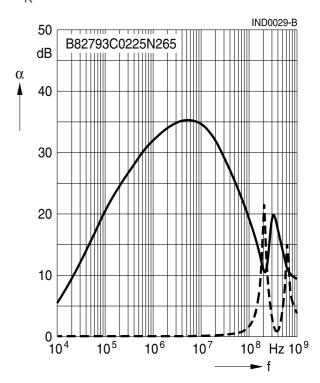
$$L_{R} = 1.0 \text{ mH}$$



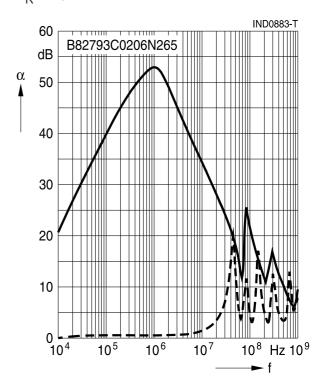
$$L_{R} = 4.7 \text{ mH}$$



$$L_{R} = 2.2 \text{ mH}$$



$$L_R = 20 \text{ mH}$$



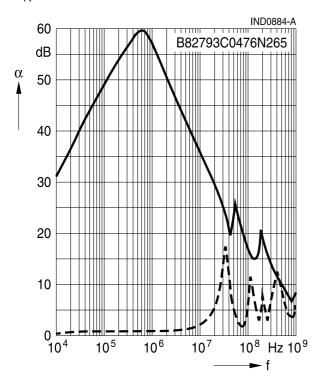
SMD

Insertion loss α (typical values at $|Z| = 50 \Omega$, +20 °C)

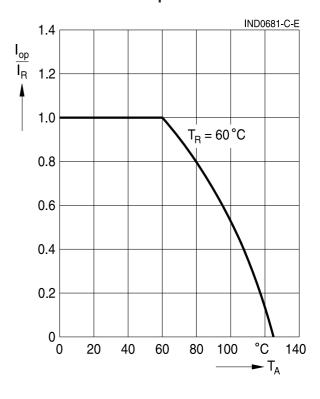
asymmetrical, all branches in parallel (common mode)

- - - - - symmetrical (differential mode)

 $L_R = 47 \text{ mH}$



Current derating I_{op}/I_R versus ambient temperature

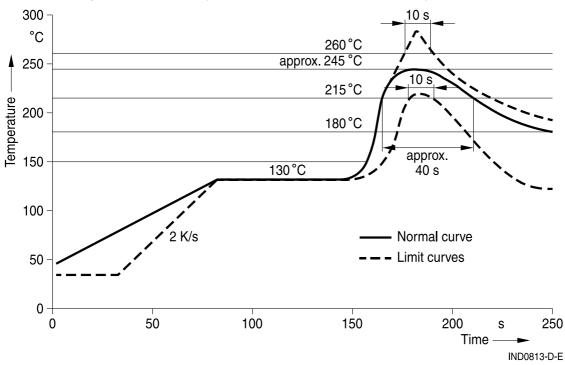


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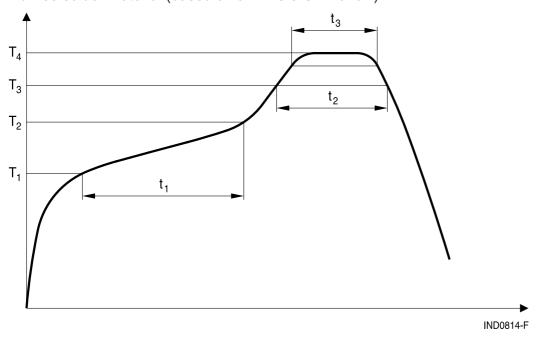
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Recommended reflow soldering curve

Pb containing solder material (based on CECC 00802 edition 2)



Pb-free solder material (based on JEDEC J-STD 020D)



T ₁ °C	T ₂ °C	T ₃ °C	T ₄ °C	t ₁	t ₂	t ₃
150	200	217	250	< 110	< 90	< 40 @ T ₄ –5 °C

Time from +25 $^{\circ}$ C to T₄: max 300 s Maximal numbers of reflow cycles: 3



Cautions and warnings

SMD

- Please note the recommendations in our Inductors data book (latest edition) and in the data sheets.
 - Particular attention should be paid to the derating curves given there.
 - The soldering conditions should also be observed. Temperatures quoted in relation to wave soldering refer to the pin, not the housing.
- If the components are to be washed varnished it is necessary to check whether the washing varnish agent that is used has a negative effect on the wire insulation, any plastics that are used, or on glued joints. In particular, it is possible for washing varnish agent residues to have a negative effect in the long-term on wire insulation.

 Washing processes may damage the product due to the possible static or cyclic mechanical loads (e.g. ultrasonic cleaning). They may cause cracks to develop on the product and its parts, which might lead to reduced reliability or lifetime.
- The following points must be observed if the components are potted in customer applications:
 - Many potting materials shrink as they harden. They therefore exert a pressure on the plastic housing or core. This pressure can have a deleterious effect on electrical properties, and in extreme cases can damage the core or plastic housing mechanically.
 - It is necessary to check whether the potting material used attacks or destroys the wire insulation, plastics or glue.
 - The effect of the potting material can change the high-frequency behaviour of the components.
- Ferrites are sensitive to direct impact. This can cause the core material to flake, or lead to breakage of the core.
- Even for customer-specific products, conclusive validation of the component in the circuit can only be carried out by the customer.

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